



TEXAS Lecture 21: Evaporation, part 2 Lecture 22: Sputtering, part 1 How can we control the mean free path of Describe the basic components of a the vapor? sputter system • Explain the view factor, 1/r² deposition rate How is good step coverage achieved in a dependence, and their impact on acrosssputtering system? wafer uniformity Define "sputter yield" Why is shadowing/step coverage a Explain the operation and effects of problem, and what can we do about it? magnetron sputtering · Explain the advantages and disadvantages of evaporation © Chris Mack, 2013

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Lecture 23: Sputtering, part 2

- How is step coverage controlled in sputter deposition systems?
- What step coverage is needed for the via fill application?
- What causes stress in deposited films, and how is it measured?
- How many aspects of film quality can you name?

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Lecture 24: Chemical Vapor Deposition, part 1

- Why is heterogeneous CVD preferred over homogeneous CVD?
- What are the two steps in our very simplified mechanism for CVD?
- Explain diffusion-controlled vs. reactioncontrolled regimes for CVD?

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How does one switch between reactioncontrolled and diffusion-controlled regimes? How does the regime (reaction- vs. diffusion-

- How does the regime (reaction- vs. diffusioncontrolled) affect CVD system design?
- How does pressure affect deposition rate?
- Explain the advantages and disadvantages of atmospheric CVD, LPCVD, and PECVD

Lecture 26: Deposition Processes

- Name four common methods of depositing thin films on a wafer.
- What is epitaxial silicon?
- What important metal is commonly deposited using CVD?
- How is CVD oxide different from thermally grown oxide?

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Lecture 29: Device Interconnect, part 2

- Why is interconnect such a big problem today?
- What gives rise to interconnect delay?
- What are five ways to reduce interconnect delay?

Lecture 30: Chemical Mechanical Polishing (CMP)

- Name three planarization techniques. Which technique is better, and why?
- What two adjustable polishing parameters control the polish rate?
- Name three CMOS process steps that require CMP
- What are the two biggest problems associated with CMP?

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Lecture 31: Copper D	ual Damascene
 Why must an additive pr pattern copper versus th subtractive process? 	
 What are the steps invol deposition? 	ved in copper
Where does the term "da from?	amascene" come

• Why must copper be kept away from the silicon device?

Lecture 32: Semiconductor Manufacturing: Yield and Defects

- What are the two major types of die yield loss?
- What are the two parameters in our simple yield model?
- What is "DFM"?

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	niconductor Manufacturing: Process Control (SPC)	Lecture	e 34: Etch, part 1
 What are the W What do you do alarm? What is the difference of the comparison of the comparis	ding principle of SPC? /estern Electric rules? o when there is an SPC erence between C _p and es mediocre, good, and ?	 Define etch se Define anisotr What common isotropic resul What are typic semiconductor 	opy n style of etch produces ts? cal etch goals in
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Lecture 35: Etch, part 2

- Describe the components of a sputter etch system
- How does sputter etching achieve high anisotropy, and why is its selectivity low?
- How is plasma etching different from sputter etching?
- How does plasma etching achieve high selectivity, and why is its anisotropy low?

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Lecture 36: Etch, part 3

- What problem is reactive ion etching trying to solve?
- How does RIE work?
- What is sidewall passivation?
- What are the characteristics of barrel etchers and why are they used?
- Why are high density plasma systems popular?

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Describe trenching and its effects
Define macroloading and microloading
Why might one use endpoint detection?
What is the "Bosch process"?